

Search Notes

Application/Control No.

10/041,005

Examiner

Shin-Hon Chen

Applicant(s)/Patent under
Reexamination

HALASZ ET AL.

Art Unit

2131

SEARCHED

Class	Subclass	Date	Examiner
713	168,171, 181,183	9/25/2006	S.C.

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPAT, PGPUB, DERWENT, EPO, JPO (BRS search)	9/25/2006	S.C.